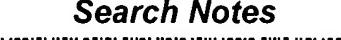


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/519,762	IMAI ET AL.
	Examiner	Art Unit
	PHAN T.H. PALMER	2874

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner